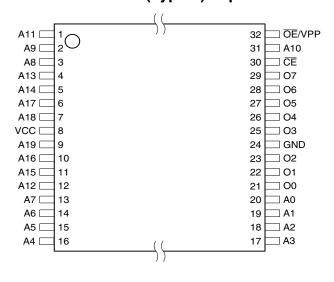


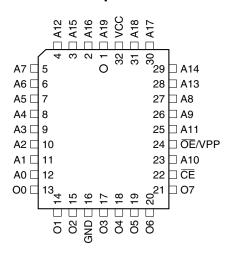
2. Pin Configurations

Pin Name	Function
A0 - A19	Addresses
00 - 07	Outputs
CE	Chip Enable
ŌĒ/VPP	Output Enable/Program Supply

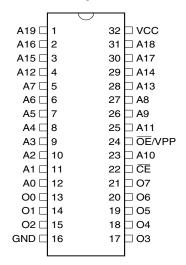
2.1 32-lead TSOP (Type 1) Top View



2.3 32-lead PLCC Top View



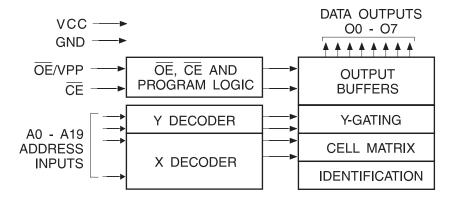
2.2 32-lead PDIP Top View



3. System Considerations

Switching between active and standby conditions via the Chip Enable pin may produce transient voltage excursions. Unless accommodated by the system design, these transients may exceed datasheet limits, resulting in device non-conformance. At a minimum, a 0.1 μF high frequency, low inherent inductance, ceramic capacitor should be utilized for each device. This capacitor should be connected between the V_{CC} and Ground terminals of the device, as close to the device as possible. Additionally, to stabilize the supply voltage level on printed circuit boards with large EPROM arrays, a 4.7 μF bulk electrolytic capacitor should be utilized, again connected between the V_{CC} and Ground terminals. This capacitor should be positioned as close as possible to the point where the power supply is connected to the array.

4. Block Diagram



5. Absolute Maximum Ratings*

	_
Temperature Under Bias	55°C to +125°C
Storage Temperature	65°C to +150°C
Voltage on Any Pin with Respect to Ground	2.0V to +7.0V ⁽¹⁾
Voltage on A9 with Respect to Ground	2.0V to +14.0V ⁽¹⁾
V _{PP} Supply Voltage with Respect to Ground	2.0V to +14.0V ⁽¹⁾
Integrated UV Erase Dose	7258 W•sec/cm ²

*NOTICE:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note: 1. Minimum voltage is -0.6V DC which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is $V_{CC} + 0.75V$ DC which may overshoot to +7.0V for pulses of less than 20 ns.





Operating Modes

Mode/Pin	CE	OE/V _{PP}	Ai	Outputs
Read	V _{IL}	V _{IL}	Ai	D _{OUT}
Output Disable	X	V _{IH}	X ⁽¹⁾	High Z
Standby	V _{IH}	X	X	High Z
Rapid Program ⁽²⁾	V _{IL}	V _{PP}	Ai	D _{IN}
PGM Verify	V _{IL}	V _{IL}	Ai	D _{OUT}
PGM Inhibit	V _{IH}	V_{PP}	X	High Z
Product Identification ⁽⁴⁾	V _{IL}	V _{IL}	$A9 = V_{H}^{(3)}$ $A0 = V_{IH} \text{ or } V_{IL}$ $A1 - A19 = V_{IL}$	Identification Code

- Notes: 1. X can be V_{IL} or V_{IH.}
 - 2. Refer to Programming Characteristics.
 - 3. $V_H = 12.0 \pm 0.5 V$.
 - 4. Two identifier bytes may be selected. All Ai inputs are held low (V_{IL}) , except A9 which is set to V_H and A0 which is toggled low (V_{IL}) to select the Manufacturer's Identification byte and high (V_{IH}) to select the Device Code byte.

DC and AC Operating Conditions for Read Operation

	AT27C080-90
Industrial Operating Temperature (Case)	-40° C - 85° C
V _{CC} Power Supply	5V ± 10%

DC and Operating Characteristics for Read Operation

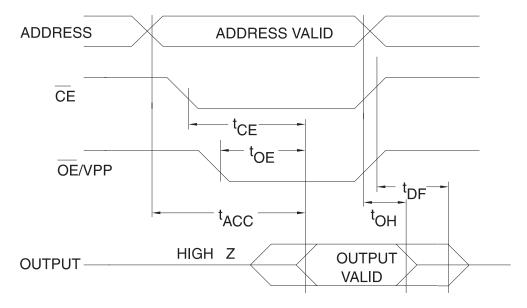
Symbol	Parameter	Condition	Min	Max	Units
I _{LI}	Input Load Current	$V_{IN} = 0V$ to V_{CC} (Com., Ind.)		±1.0	μΑ
I _{LO}	Output Leakage Current	$V_{OUT} = 0V$ to V_{CC} (Com., Ind.)		±5.0	μΑ
I _{SB} V _{CO}	V (1) Otomolles Commont	I_{SB1} (CMOS), $\overline{CE} = V_{CC} \pm 0.3V$		100	μА
	V _{CC} ⁽¹⁾ Standby Current	I_{SB2} (TTL), \overline{CE} = 2.0 to V_{CC} + 0.5V		1.0	mA
I _{CC}	V _{CC} Active Current	$f = 5 \text{ MHz}, I_{OUT} = 0 \text{ mA}, \overline{CE} = V_{IL}$		40	mA
V _{IL}	Input Low Voltage		-0.6	0.8	V
V _{IH}	Input High Voltage		2.0	V _{CC} + 0.5	V
V _{OL}	Output Low Voltage	I _{OL} = 2.1 mA		0.4	V
V _{OH}	Output High Voltage	I _{OH} = -400 μA	2.4		V

1. V_{CC} must be applied simultaneously or before \overline{OE}/V_{PP} , and removed simultaneously or after \overline{OE}/V_{PP} . Note:

AC Characteristics for Read Operation

			AT27C	AT27C080-90		
Symbol	Parameter	Condition	Min	Max	Units	
t _{ACC} ⁽⁴⁾	Address to Output Delay	$\overline{CE} = \overline{OE}/V_{PP}$ $= V_{IL}$		90	ns	
t _{CE} (3)	CE to Output Delay	OE = V _{IL}		90	ns	
t _{OE} (3)(4)	OE to Output Delay	OE to Output Delay		20	ns	
t _{DF} ⁽²⁾⁽⁵⁾	OE or CE High to Output Float, whiche		30	ns		
t _{OH}	Output Hold from Address, $\overline{\text{CE}}$ or $\overline{\text{OE}}/\text{V}$	0		ns		

10. AC Waveforms for Read Operation⁽¹⁾

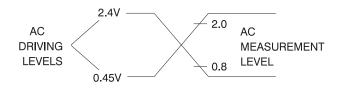


- Notes: 1. Timing measurement references are 0.8V and 2.0V. Input AC drive levels are 0.45V and 2.4V, unless otherwise specified.
 - 2. t_{DF} is specified form \overline{OE}/V_{PP} or \overline{CE} , whichever occurs first. Output float is defined as the point when data is no longer driven.
 - 3. $\overline{\text{OE}}/\text{V}_{PP}$ may be delayed up to t_{CE} t_{OE} after the falling edge of $\overline{\text{CE}}$ without impact on t_{CE} .
 - 4. $\overline{\text{OE}}/\text{V}_{PP}$ may be delayed up to t_{ACC} t_{OE} after the address is valid without impact on t_{ACC} .
 - 5. This parameter is only sampled and is not 100% tested.



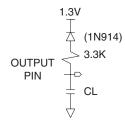


11. Input Test Waveform and Measurement Levels



 $t_{\rm R},\,t_{\rm F}\!<\!20$ ns (10% to 90%)

12. Output Test Load



Note: CL = 100 pF including jig capacitance.

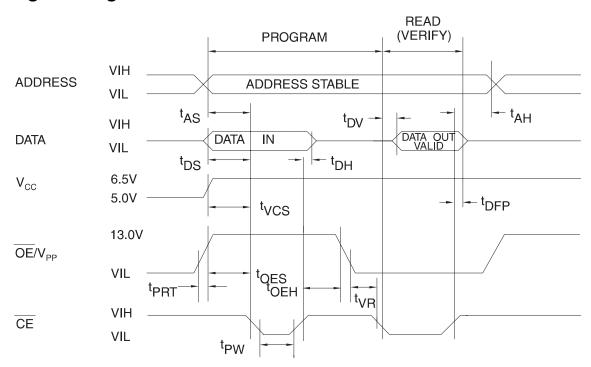
13. Pin Capacitance

 $f = 1 \text{ MHz}, T = 25^{\circ} C^{(1)}$

Symbol	Тур	Max	Units	Conditions
C _{IN}	4	8	pF	$V_{IN} = 0V$
C _{OUT}	8	12	pF	V _{OUT} = 0V

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.

14. Programming Waveforms



Notes: 1. The Input Timing reference is 0.8V for $V_{\rm IL}$ and 2.0V for $V_{\rm IH}$.

2. t_{OE} and t_{DFP} are characteristics of the device but must be accommodated by the programmer.





15. DC Programming Characteristics

 $T_A = 25 \pm 5$ °C, $V_{CC} = 6.5 \pm 0.25$ V, $\overline{OE}/V_{PP} = 13.0 \pm 0.25$ V

			Lin		
Symbol	Parameter	Test Conditions	Min	Max	Units
ILI	Input Load Current	$V_{IN} = V_{IL}, V_{IH}$		±10	μΑ
V _{IL}	Input Low Level		-0.6	0.8	V
V _{IH}	Input High Level		2.0	V _{CC} + 1.0	V
V _{OL}	Output Low Voltage	I _{OL} = 2.1 mA		0.4	V
V _{OH}	Output High Voltage	I _{OH} = -400 μA	2.4		V
I _{CC2}	V _{CC} Supply Current (Program and Verify)			40	mA
I _{PP2}	OE/V _{PP} Supply Current	CE = V _{IL}		25	mA
V _{ID}	A9 Product Identification Voltage		11.5	12.5	V

16. AC Programming Characteristics

 $T_A = 25 \pm 5$ °C, $V_{CC} = 6.5 \pm 0.25$ V, $\overline{OE}/V_{PP} = 13.0 \pm 0.25$ V

			Lir		
Symbol	Parameter	Test Conditions ⁽¹⁾	Min	Max	Units
t _{AS}	Address Setup Time		2.0		μs
t _{OES}	OE/V _{PP} Setup Time		2.0		μs
t _{OEH}	OE/V _{PP} Hold Time	Input Rise and Fall Times:	2.0		μs
t _{DS}	Data SetupTime	(10% to 90%) 20 ns	2.0		μs
t _{AH}	Address Hold Time	Input Pulse Levels:	0.0		μs
t _{DH}	Data Hold Time	0.45V to 2.4V	2.0		μs
t _{DFP}	CE High to Output Float Delay ⁽²⁾		0.0	130	ns
t _{vcs}	V _{CC} Setup Time	Input Timing Reference Level: 0.8V to 2.0V	2.0		μs
t _{PW}	CE Program Pulse Width ⁽³⁾	0.00 10 2.00	47.5	52.5	μs
t _{DV}	Data Valid from CE	Output Timing Reference Level:		1.0	μs
t _{VR}	OE/V _{PP} Recovery Time	0.8V to 2.0V	2.0		ns
t _{PRT}	OE/V _{PP} Pulse Rise Time During Programming		50		ns

Notes: 1. V_{CC} must be applied simultaneously or before \overline{OE}/V_{PP} and removed simultaneously or after \overline{OE}/V_{PP}

- 2. This parameter is only sampled and is not 100% tested. Output Float is defined as the point where data is no longer driven see timing diagram.
- 3. Program Pulse width tolerance is 50 μ s \pm 5%.

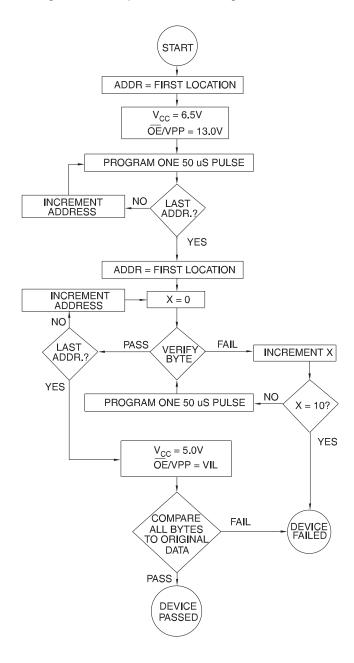
17. Atmel's AT27C080 Integrated Product Identification Code

	Pins									
Codes	A0	07	06	O 5	04	О3	O2	01	00	Hex Data
Manufacturer	0	0	0	0	1	1	1	1	0	1E
Device Type	1	1	0	0	0	1	0	1	0	8A

AT27C080

18. Rapid Programming Algorithm

A 50 μ s $\overline{\text{CE}}$ pulse width is used to program. The address is set to the first location. V_{CC} is raised to 6.5V and $\overline{\text{OE}}/V_{PP}$ is raised to 13.0V. Each address is first programmed with one 50 μ s $\overline{\text{CE}}$ pulse without verification. Then a verification reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive 50 μ s pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked. $\overline{\text{OE}}/V_{PP}$ is then lowered to V_{IL} and V_{CC} to 5.0V. All bytes are read again and compared with the original data to determine if the device passes or fails.







19. Ordering Information

19.1 Standard Package

t _{ACC}	I _{CC} (mA)				
(ns)	Active	Standby	Ordering Code	Package	Operation Range
90	40	0.1	AT27C080-90JI AT27C080-90PI AT27C080-90TI	32J 32P6 32T	Industrial (-40° C to 85° C)

Note:

Not recommended for new designs. Use Green package option.

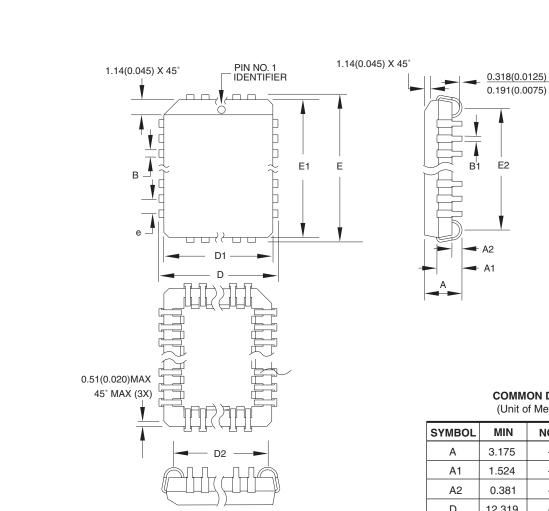
19.2 Green Package (Pb/Halide-free)

t _{ACC}	I _{CC} (mA)				
(ns)	Active	Standby	Ordering Code	Package	Operation Range
90	40	0.1	AT27C080-90JU AT27C080-90PU AT27C080-90TU	32J 32P6 32T	Industrial (-40° C to 85° C)

Package Type		
32J	32-lead, Plastic J-leaded Chip Carrier (PLCC)	
32P6	32-lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)	
32T	32-lead, Plastic Thin Small Outline Package (TSOP)	

20. Package Information

20.1 32J - PLCC



Notes:

- 1. This package conforms to JEDEC reference MS-016, Variation AE.
- Dimensions D1 and E1 do not include mold protrusion.
 Allowable protrusion is .010"(0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
- 3. Lead coplanarity is 0.004" (0.102 mm) maximum.

COMMON DIMENSIONS

(Unit of Measure = mm)

	(Office) Measure = min)				
	SYMBOL	MIN	NOM	MAX	NOTE
	Α	3.175	_	3.556	
	A1	1.524	_	2.413	
	A2	0.381	_	_	
	D	12.319	_	12.573	
ſ	D1	11.354	_	11.506	Note 2
	D2	9.906	_	10.922	
	Е	14.859	_	15.113	
	E1	13.894	_	14.046	Note 2
	E2	12.471	_	13.487	
	В	0.660	_	0.813	
	B1	0.330	_	0.533	
ľ	е		1.270 TYF)	

10/04/01

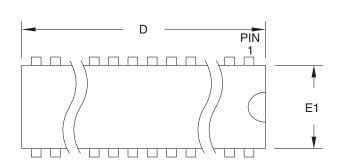
IIILE			
32J , 32-	-lead, Plastic J-le	eaded Chip Ca	rrier (PLCC)

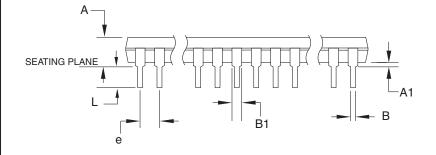
DRAWING NO.	REV.
32J	В

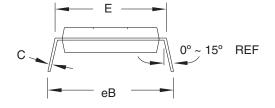




20.2 32P6 - PDIP







Note: 1. Dimensions D and E1 do not include mold Flash or Protrusion.

Mold Flash or Protrusion shall not exceed 0.25 mm (0.010").

COMMON DIMENSIONS

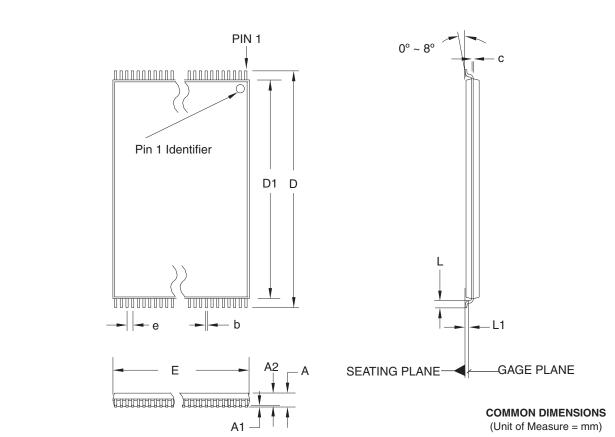
(Unit of Measure = mm)

(Gilli of Modedio = Hill)				
SYMBOL	MIN	NOM	MAX	NOTE
Α	_	_	4.826	
A1	0.381	_	_	
D	41.783	_	42.291	Note 1
E	15.240	_	15.875	
E1	13.462	_	13.970	Note 1
В	0.356	_	0.559	
B1	1.041	_	1.651	
L	3.048	_	3.556	
С	0.203	-	0.381	
eB	15.494	_	17.526	
е	2.540 TYP			

09/28/01

		DRAWING NO.	REV.
2325 Orchard Parkway San Jose, CA 95131	32P6 , 32-lead (0.600"/15.24 mm Wide) Plastic Dual Inline Package (PDIP)	32P6	В

20.3 32T - TSOP



Notes:

- 1. This package conforms to JEDEC reference MO-142, Variation BD.
- 2. Dimensions D1 and E do not include mold protrusion. Allowable protrusion on E is 0.15 mm per side and on D1 is 0.25 mm per side.

TITLE

3. Lead coplanarity is 0.10 mm maximum.

SYMBOL	MIN	NOM	MAX	NOTE
Α	_	_	1.20	
A1	0.05	_	0.15	
A2	0.95	1.00	1.05	
D	19.80	20.00	20.20	
D1	18.30	18.40	18.50	Note 2
Е	7.90	8.00	8.10	Note 2
L	0.50	0.60	0.70	
L1	0.25 BASIC			
b	0.17	0.22	0.27	
С	0.10	_	0.21	
е	(0.50 BASI	<u> </u>	

10/18/01

4 mei	2325 Orchard Parkway
AIIIIEL	2325 Orchard Parkway San Jose, CA 95131

32T, 32-lead (8 x 20 mm Package) Plastic Thin Small Outline
Package, Type I (TSOP)

DRAWING NO.	REV.
32T	В





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